

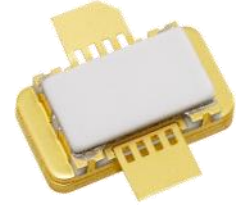
## ■ Features

- High Voltage Operation :  $V_{DS}=50V$
- High Power : 53.8dBm (typ.) @  $P_{sat}$
- Proven Reliability

## ■ Description

Sumitomo Electric's GaN-HEMT offers high efficiency, ease of matching, greater consistency and broad bandwidth for high power L-band amplifiers with 50V operation, and gives you higher gain.

This new product is ideally suited for use from 1.8GHz to 2.0GHz W-CDMA and LTE design requirements as it offers high gain, long term reliability and ease of use.



### ABSOLUTE MAXIMUM RATINGS ( Case Temperature $T_c=25\text{deg.C}$ )

Item	Symbol	Condition	Rating	Unit
Operating Voltage	$V_{DS}$		55	V
Drain-Source Voltage	$V_{DS}$	$V_{GS}=-8V$	160	V
Gate-Source Voltage	$V_{GS}$		-15	V
Total Power Dissipation	$P_t$		160.7	W
Storage Temperature	$T_{stg}$		-65 to +175	deg.C
Channel Temperature	$T_{ch}$		250	deg.C

### RECOMMENDED OPERATING CONDITION

Item	Symbol	Condition	Limit	Unit
DC Input Voltage	$V_{DS}$		$\leq 55$	V
Forward Gate Current	$I_{GF}$	$R_G=5\text{ ohm}$	$\leq 406$	mA
Reverse Gate Current	$I_{GR}$	$R_G=5\text{ ohm}$	$\geq -13.8$	mA
Channel Temperature	$T_{ch}$		$\leq 200$	deg.C
Average Output Power	$P_{ave.}$		$\leq 51.0$	dBm

### ELECTRICAL CHARACTERISTICS ( Case Temperature $T_c=25\text{deg.C}$ )

Item	Symbol	Condition	Limit			Unit
			Min.	Typ.	Max.	
Pinch-Off Voltage	$V_p$	$V_{DS}=50V$ $I_{DS}=48mA$	-4.0	-	-2.0	V
Saturated Power	$P_{sat} *1$	$V_{DS}=50V$	53.2	53.8	-	dBm
Drain Efficiency at $P_{sat}$	$DE *1$	$I_{DS(DC)}=0mA$ $f=1.88GHz$	50.0	60.0	-	%
Power Gain	$G_p *2$	$V_{DS}=50V$ $I_{DS(DC)}=800mA$ $f=1.88GHz$	15.5	16.5	-	dB
Thermal Resistance	$R_{th}$	Channel to Case at 105W $P_{DC}$	-	1.2	1.4	deg.C/W
Load Mismatch Ruggedness *3	-	VSWR 10:1	No failures			

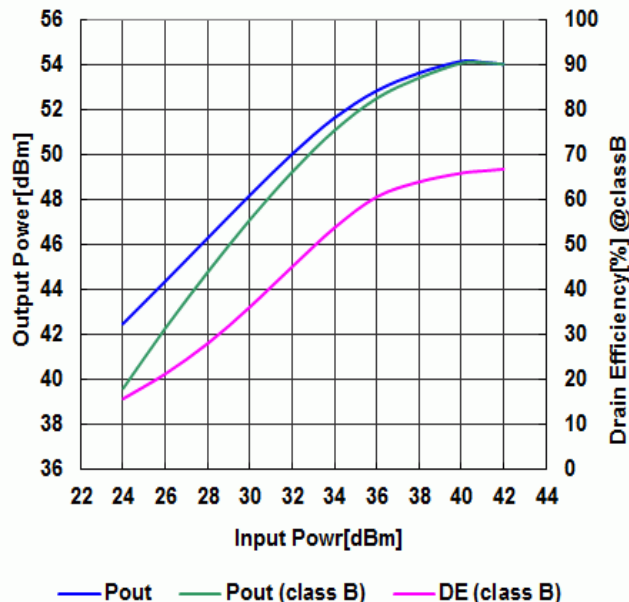
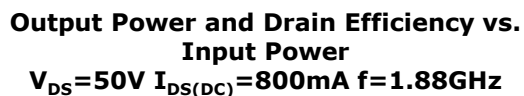
\*1 : 10%-duty RF pulse ( DC supply constant )

\*2 :  $P_{out}=46dBm$ , CW modulation Signal ( W-CDMA )

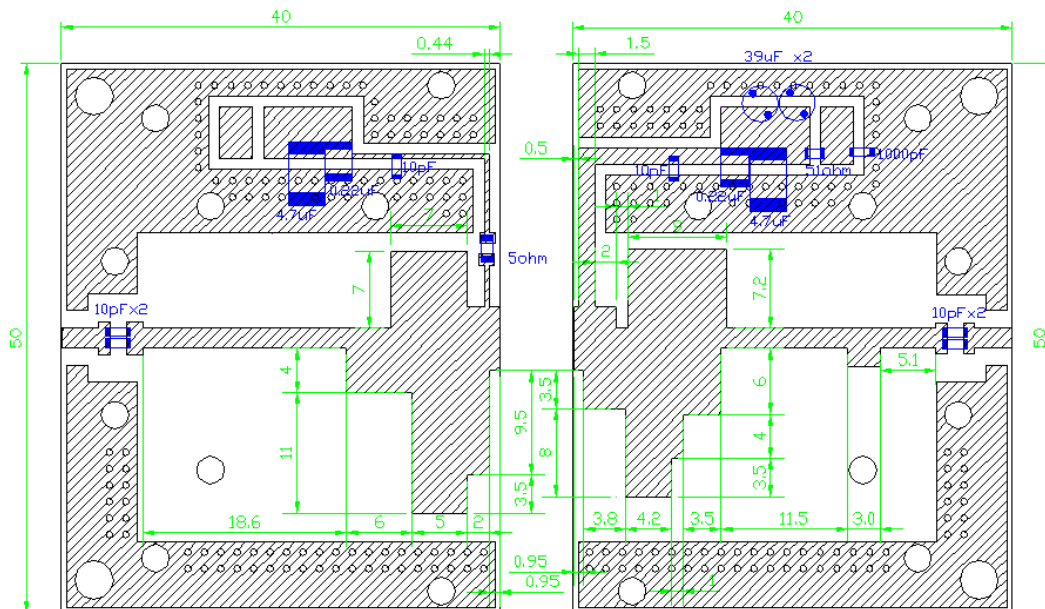
\*3 : Fixed Pin :  $P_{out}=P3dB$  at  $RL=50\text{ohm}$ , pulsed CW signal(10% duty)

RoHS Compliance	YES
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**Output Power vs. Frequency**  
 $V_{DS}=50V$   $I_{DS(DC)}=800mA$



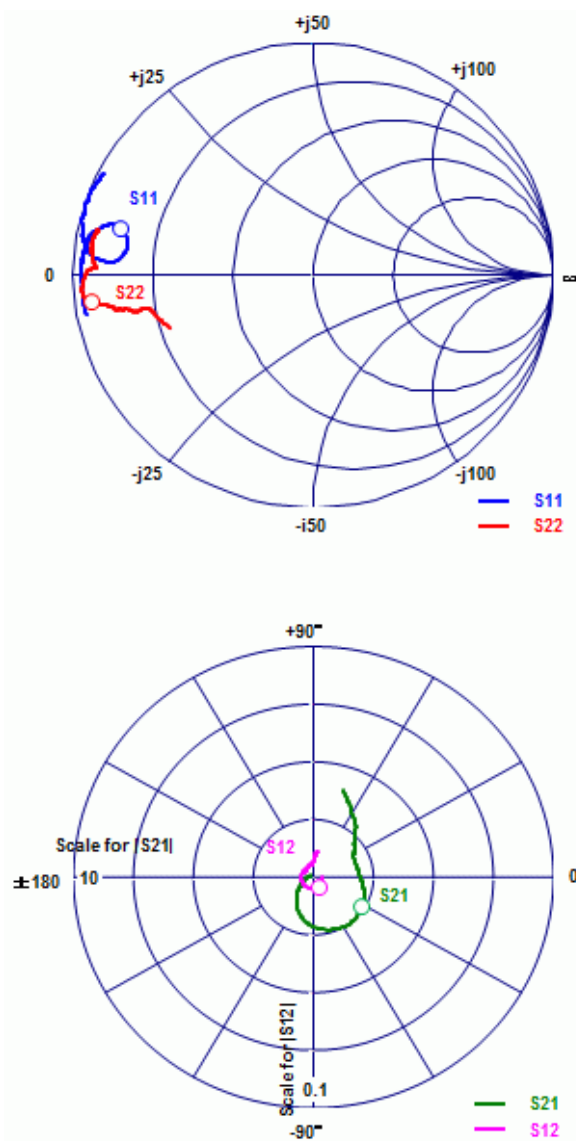
## Test Fixture



h=0.8mm  $\epsilon_r=3.5$   
Cu=18 $\mu$ m Unit : mm

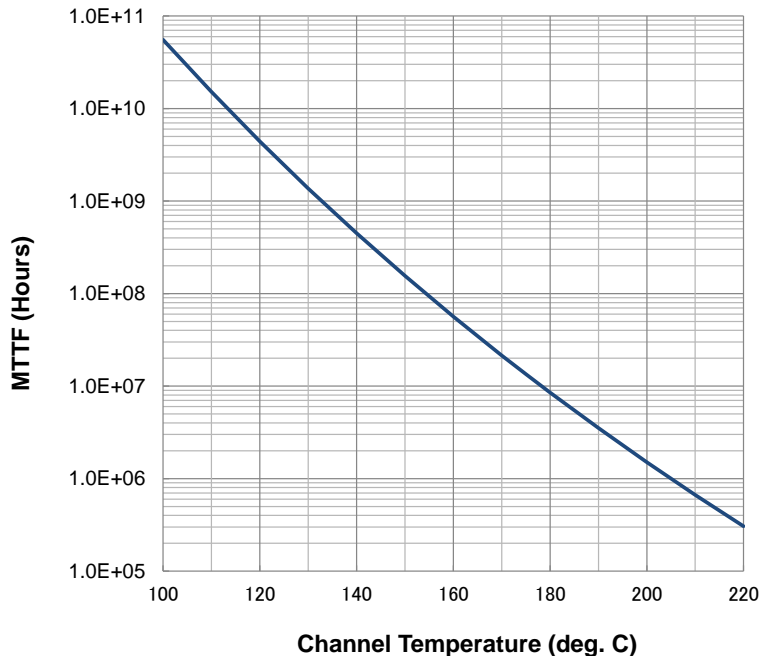
**- Reference DATA -**

**S-Parameters @VDS=50V, IDS(DC)=800mA, f=0.5 to 4.5GHz**  
**ZI = Zs = 50 ohm      Marker : 1.84GHz**



Freq.	S11		S21		S12		S22	
GHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG
0.5	0.96	-169.66	4.00	72.07	0.004	7.35	0.64	-159.28
0.6	0.97	-176.75	3.29	61.16	0.004	1.50	0.67	-163.45
0.7	0.97	176.66	2.80	50.41	0.004	-4.67	0.70	-167.99
0.8	0.96	175.44	2.45	45.52	0.004	-5.10	0.72	-168.23
0.9	0.96	174.43	2.24	41.00	0.004	-5.38	0.74	-168.15
1.0	0.96	173.59	2.10	35.76	0.004	-4.31	0.75	-168.02
1.1	0.96	172.65	1.97	30.92	0.004	-3.99	0.77	-168.45
1.2	0.96	171.63	1.87	25.83	0.004	-6.67	0.79	-169.36
1.3	0.95	170.18	1.85	19.92	0.004	-9.23	0.81	-169.37
1.4	0.94	169.34	1.87	13.57	0.004	-12.54	0.83	-169.67
1.5	0.94	168.31	1.90	7.37	0.004	-17.61	0.84	-170.22
1.6	0.91	167.17	1.97	-0.66	0.004	-23.50	0.86	-171.14
1.7	0.88	165.64	2.12	-11.45	0.004	-33.41	0.88	-171.59
1.8	0.85	165.45	2.35	-25.59	0.005	-52.68	0.91	-172.15
1.9	0.80	167.22	2.49	-44.42	0.005	-80.91	0.96	-173.74
2.0	0.78	171.28	2.46	-65.97	0.005	-116.10	0.97	-176.45
2.1	0.82	175.47	2.14	-90.12	0.005	-152.81	0.95	-179.43
2.2	0.87	176.04	1.70	-109.48	0.005	172.92	0.94	179.10
2.3	0.92	175.11	1.31	-122.84	0.005	148.83	0.93	178.32
2.4	0.94	173.93	1.02	-132.89	0.005	132.99	0.92	177.95
2.5	0.96	172.22	0.80	-140.53	0.005	120.98	0.91	177.89
2.6	0.97	170.95	0.64	-147.14	0.005	112.07	0.91	177.62
2.7	0.98	169.83	0.53	-152.17	0.005	106.65	0.91	177.25
2.8	0.98	168.65	0.45	-156.55	0.005	102.53	0.91	176.87
2.9	0.98	167.86	0.38	-160.95	0.005	99.08	0.91	176.61
3.0	0.99	166.90	0.33	-164.13	0.005	98.34	0.92	176.28
3.1	0.99	166.05	0.29	-167.23	0.006	94.50	0.92	175.59
3.2	0.99	165.13	0.26	-170.31	0.006	94.16	0.92	175.07
3.3	0.99	164.27	0.24	-173.64	0.006	92.20	0.93	174.77
3.4	1.00	163.39	0.22	-176.56	0.006	92.47	0.93	174.39
3.5	1.00	162.70	0.20	-179.22	0.007	91.23	0.93	173.59
3.6	1.00	161.61	0.19	177.83	0.007	90.84	0.93	172.72
3.7	0.99	160.82	0.18	174.07	0.007	88.08	0.93	172.47
3.8	0.99	159.83	0.17	170.69	0.008	88.05	0.93	171.75
3.9	1.00	158.81	0.17	167.38	0.008	87.81	0.93	171.09
4.0	0.99	157.91	0.16	163.88	0.009	85.34	0.93	170.37
4.1	0.99	157.31	0.16	160.34	0.009	85.23	0.93	169.93
4.2	0.99	156.30	0.16	156.83	0.009	84.21	0.93	169.54
4.3	0.99	155.07	0.16	152.74	0.010	84.43	0.93	168.62
4.4	0.98	154.14	0.16	148.53	0.011	84.02	0.92	168.12
4.5	0.98	153.32	0.17	144.44	0.011	81.51	0.92	167.60

### MTTF Calculation – Estimated MTTF –



Ea=1.6eV  
Confidence Level=90%

Channel Temp (deg.C)	MTTF (Hours)
160	5.98 x 10 <sup>7</sup>
180	9.02 x 10 <sup>6</sup>
200	1.60 x 10 <sup>6</sup>

$$AF = \exp\left[\frac{-E_a}{k} \left(\frac{1}{T_{\text{stress}}} - \frac{1}{T_{\text{use}}}\right)\right]$$

$$MTTF_{\text{use}} = MTTF_{\text{stress}} \cdot AF$$

Where;

AF: acceleration factor

Ea: activation energy (1.6 eV)

k: Boltzman's constant (8.62 x 10<sup>-5</sup> eV/K)

T<sub>stress</sub>: stress temperature (K)

T<sub>use</sub>: use temperature (K)

### ESD characteristic

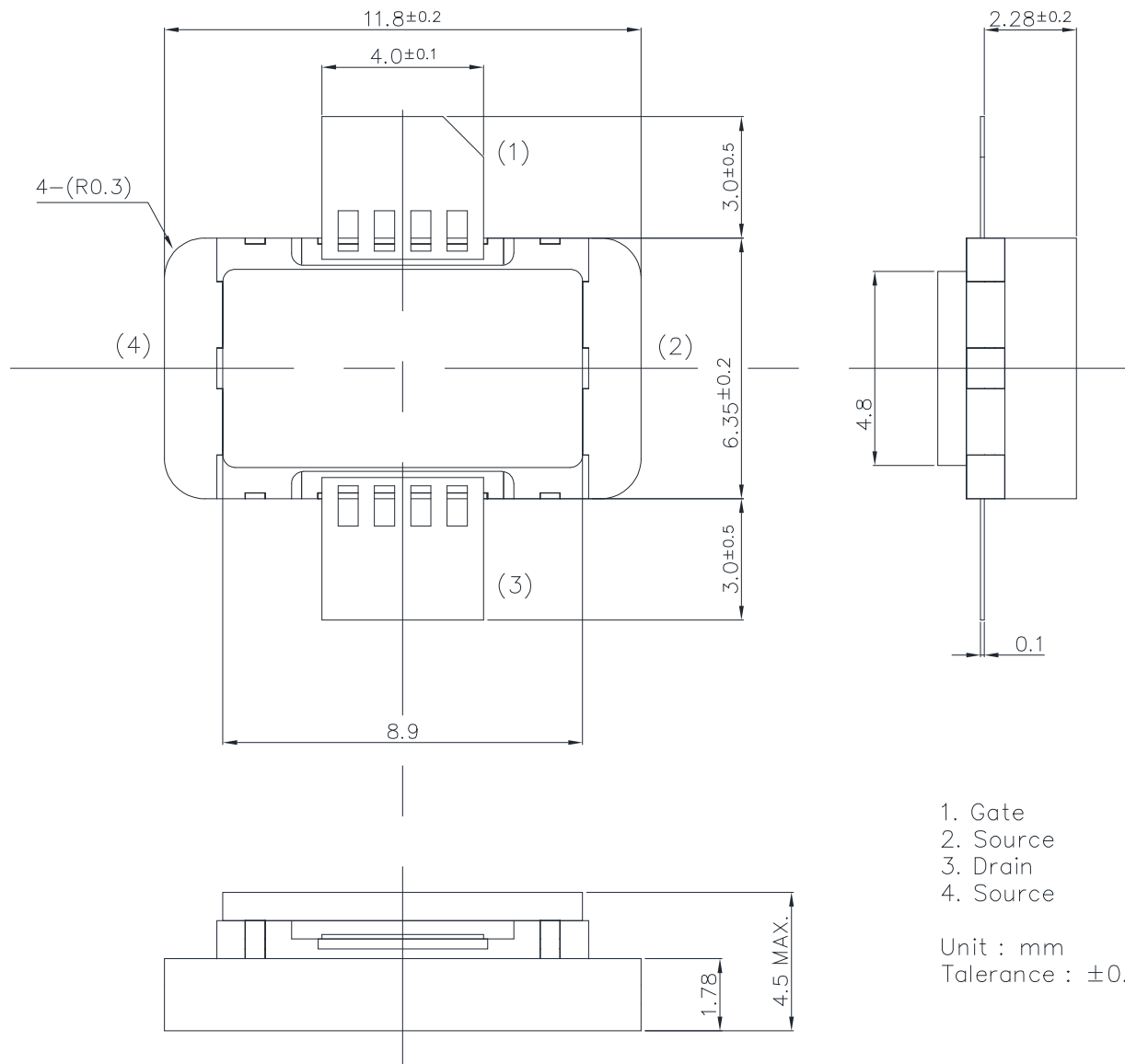
Test Methodology	Class
Human Body Model (per JESD22-A114)	1B
Machine Model (per JEIA/ESD22-A115)	A
Device Charged Model (per JESD22-C101)	IV

### Ordering Information

Part Number	MOQ / MOU	Tray Style
SGN19H240M1H	No Limitation	30pcs Tray ( 30 pockets )
SGN19H240M1H/001	No Limitation	JEDEC Tray ( 100 pockets )



**M1H Package Outline**  
**Metal-Ceramic Hermetic Package**



- 1. Gate
- 2. Source
- 3. Drain
- 4. Source

Unit : mm  
Tolerance :  $\pm 0.15$

## **For Safety, Observe the Following Procedures Environmental Management**

- Do not put this product into the mouth.
- Do not alter the form of this product into a gas, powder, or liquid through burning, crushing, or chemical processing as these by-products are dangerous to the human body if inhaled, ingested, or swallowed.
- Respect all applicable laws of the country when discarding this product.  
This product must be disposed in accordance with methods specified by applicable hazardous waste procedures.

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